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P-Channel 60-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^a	Q _g (Typ.)		
- 60	0.0486 at V _{GS} = - 10 V	- 53	76 nC		
- 00	0.0568 at V _{GS} = - 4.5 V	- 42	70110		

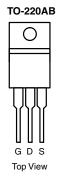
FEATURES

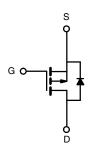
- DT-Trench Power MOSFET
- 100 % UIS Tested



APPLICATIONS

Load Switch





P-Channel	MOSEET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V_{DS}	- 60	V	
Gate-Source Voltage		V_{GS}	± 20	7 v	
	T _C = 25 °C		- 53 ^a		
Continuous Drain Current /T = 150 °C)	T _C = 70 °C		- 46.8		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	9.2 ^b	A	
	T _A = 70 °C		- 8.1 ^b		
Pulsed Drain Current		I _{DM}	- 150	1	
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	- 45		
Single Pulse Avalanche Energy			101	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C	I.	53 ^a	A	
Continuous Source-Drain blode Current	T _A = 25 °C	I _S	2.1 ^b	_ ^	
	T _C = 25 °C		104.2 ^a		
Maximum Daylar Dissipation	T _C = 70 °C	[66.7 ^a	١٨/	
Maximum Power Dissipation	T _A = 25 °C	P _D	3.1 ^b	W	
	T _A = 70 °C		2 ^b		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^b	Steady State	R_{thJA}	33	40	°C/W		
Maximum Junction-to-Case	Steady State	R _{thJC}	0.98	1.2			

Notes:

- a. Based on T_C = 25 °C.
- b. Surface mounted on 1" x 1" FR4 board.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 60			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		68		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	i _D = - 250 μA		- 5.2			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1		- 3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 60 V, V _{GS} = 0 V	-1				
		$V_{DS} = -60 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			- 10	μΑ	
On-State Drain Current ^a	I _{D(on)}	V _{DS} = - 5 V, V _{GS} = - 10 V	- 120			Α	
Drain-Source On-State Resistance ^a	В	V _{GS} = - 10 V, I _D = - 30 A		0.0486	0.0534	Ω	
	R _{DS(on)}	$V_{GS} = -4.5 \text{ V}, I_D = -20 \text{ A}$		0.0568	0.0624		
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = - 50 A	20			S	
Dynamic ^b							
Input Capacitance	C _{iss}			3500		pF	
Output Capacitance	C _{oss}	$V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		390			
Reverse Transfer Capacitance	C _{rss}			290			
Total Cata Chausa	Qg	$V_{DS} = -30 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -55 \text{ A}$		76	115	nC	
Total Gate Charge				38	60		
Gate-Source Charge	Q_{gs}	$V_{DS} = -30 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -55 \text{ A}$		16			
Gate-Drain Charge	Q_{gd}			19			
Gate Resistance	R_{g}	f = 1 MHz		5.2		Ω	
Turn-On Delay Time	t _{d(on)}			10	15		
Rise Time	t _r	V_{DD} = - 2 V, R_L = 2 Ω		7	15	ns	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 10 A, V_{GEN} = - 10 V, R_g = 1 Ω		70	110		
Fall Time	t _f			40	60		
Drain-Source Body Diode Characteristic	S						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 53	Α	
Pulse Diode Forward Current ^a	I _{SM}				- 150		
Body Diode Voltage	V_{SD}	I _S = - 30 A		- 1	- 1.5	V	
Body Diode Reverse Recovery Time	t _{rr}			45	68	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 50 A, di/dt = 100 A/μs, T _{.I} = 25 °C		59	120	nC	
Reverse Recovery Fall Time	t _a	$ 1_F - 30 \text{ A}, \text{ awat} - 100 \text{ A/} \mu \text{s}, 1_J = 25 \text{C}$		29		ns	
Reverse Recovery Rise Time	t _b			16			

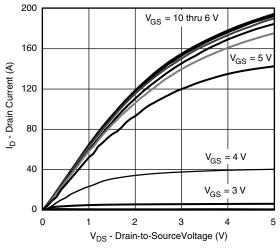
Notes:

- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

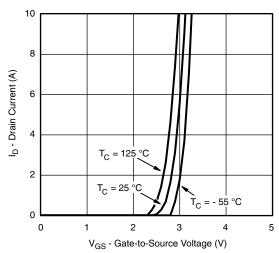
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



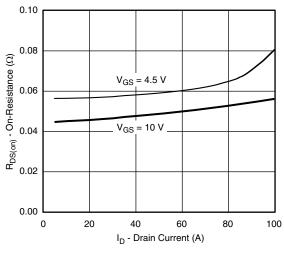
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



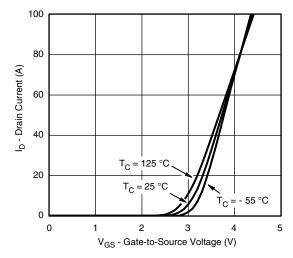
Output Characteristics



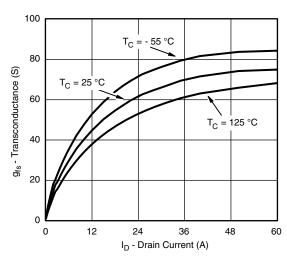
Transfer Characteristics



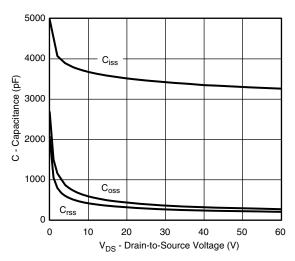
On-Resistance vs. Drain Current



Transfer Characteristics



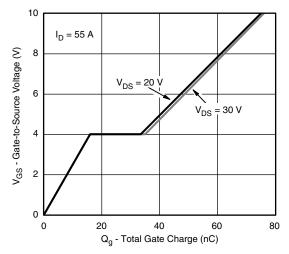
Transconductance



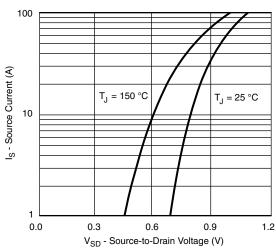
Capacitance



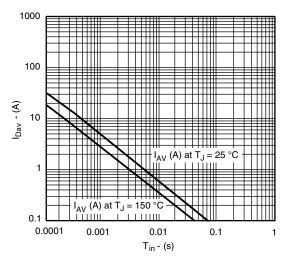
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



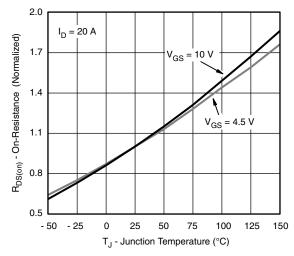
Gate Charge



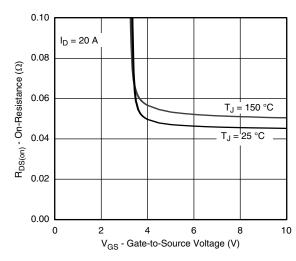
Source-Drain Diode Forward Voltage



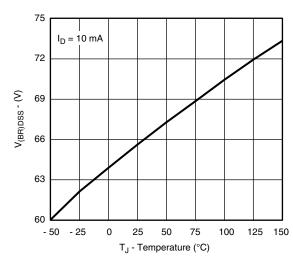
Single Pulse Avalanche Current Capability vs. Time



On-Resistance vs. Gate-to-Source Voltage



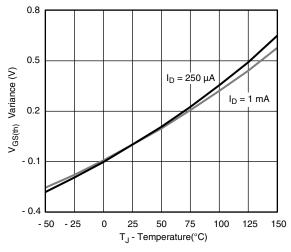
On-Resistance vs. Gate-to-Source Voltage



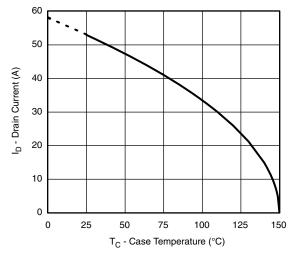
Drain-Source Breakdown Voltage vs. Junction Temperature

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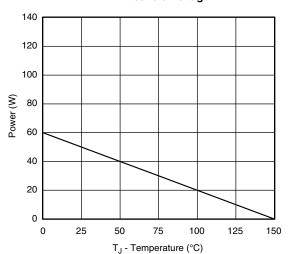
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



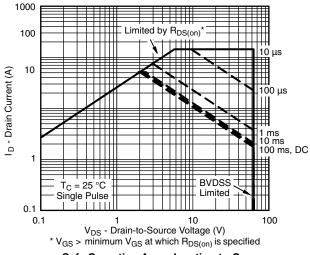
Din-Tek SEMICONDUCTOR



Threshold Voltage

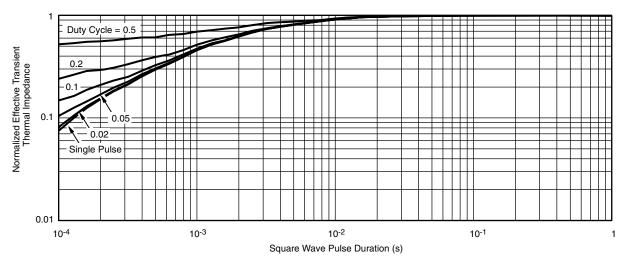


Max. Drain Current vs. Case Temperature



Power Derating, Junction-to-Case





Normalized Thermal Transient Impedance, Junction-to-Case





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